

**In the Specification:**

Please amend the specification as follows: After the fourth paragraph on Page 24, starting at Line 14, please add the following paragraph:

Fig 7d. is a signal timing diagram for a method to measure the the total  
5 capacitance for all the pixels on the selected row of the photo-conversion device of an active pixel sensor of this invention.

Please replace the last paragraph on Page 38, starting at Line 8 and extending to Page 39, with the following rewritten paragraph:

The testable APS cell coupled to the test voltage select circuit TestVSelect of  
10 Fig. 6 is used to measure the total capacitance  $C_{FD}$  of the row of pixels. Referring to Fig. 6, the voltage sources  $V_{s1}$  and  $V_{s2}$  provide the voltage levels  $V1$  and  $V2$  to the test voltage select circuit. In series with the voltage source  $V_{s1}$  is a current measuring device  $X1$  to determine the current  $I$  flowing from the voltage source  $V_{s1}$  to the test voltage select circuit. Refer back to Fig. 7d for the description of the method to  
15 measure the total capacitance  $C_{FD}$  for all the pixels on the selected row. The row select signal is held at the low voltage level (0V) to keep the transistor  $M2$  turned off. At the time  $t_0$ , the reset signal  $V_{rst}$  changes from the low voltage level ( $V0$ ) to the high voltage level ( $V_{DD}$ ) to activate the transistor  $M2$  of each APS pixel cell. At the time  $t_1$ , the switch  $S2$  is activated to place the voltage level  $V2$  at the reference distribution node  $RD$  of  
20 each pixel on the row of pixels. Once all the capacitances  $C_{FD}$  at the node  $FD$  of each

pixel is charged to the voltage level **V2**, the switch **S2** is deactivated at the time **t<sub>2</sub>**. The switch **S1** is activated at the time **t<sub>3</sub>** to place the voltage level **V1** at the reference distribution node **RD** of each pixel. As the capacitance **C<sub>FD</sub>** of all the pixels on the selected row are charged, the current **I** is recorded by the current measurement device

5 **X1** of Fig. 6. When all the capacitances **C<sub>FD</sub>** of the node **FD** of all the pixels have charged to the voltage level **V1**, the switch **S1** is deactivated at the time **t<sub>5</sub>**.